



CY7C281A CY7C282A

1K x 8 PROM

Features

- CMOS for optimum speed/power
- High speed
 - 25 ns (commercial)
 - 30 ns (military)
- Low power
 - 495 mW (commercial)
 - 660 mW (military)
- EPROM technology 100% programmable
- Slim 300-mil or standard 600-mil DIP or 28-pin LCC
- 5V $\pm 10\%$ V_{CC}, commercial and military
- TTL-compatible I/O
- Direct replacement for bipolar PROMs

- Capable of withstanding > 2001V static discharge

Functional Description

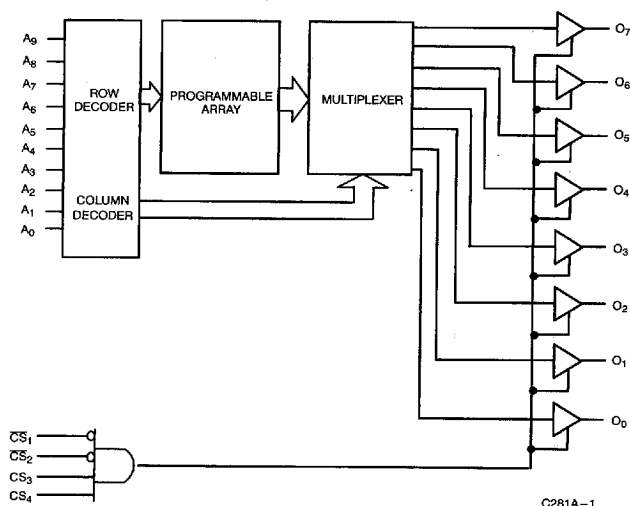
The CY7C281A and CY7C282A are high-performance 1024-word by 8-bit CMOS PROMs. They are functionally identical, but are packaged in 300-mil and 600-mil-wide packages respectively. The CY7C281A is also available in a 28-pin leadless chip carrier. The memory cells utilize proven EPROM floating-gate technology and byte-wide intelligent programming algorithms.

The CY7C281A and CY7C282A are plug-in replacements for bipolar devices and offer the advantages of lower power, superior performance, and programming

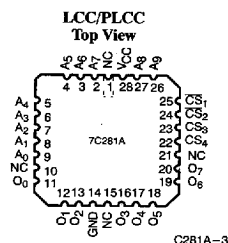
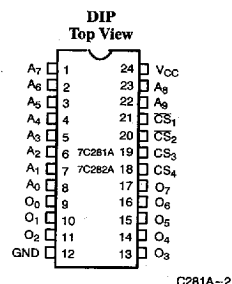
yield. The EPROM cell requires only 12.5V for the super voltage, and low current requirements allow for gang programming. The EPROM cells allow each memory location to be tested 100% because each location is written into, erased, and repeatedly exercised prior to encapsulation. Each PROM is also tested for AC performance to guarantee that after customer programming, the product will meet DC and AC specification limits.

Reading is accomplished by placing an active LOW signal on $\overline{CS}_1$ and $\overline{CS}_2$, and active HIGH signals on CS_3 and CS_4 . The contents of the memory location addressed by the address lines ($A_0 - A_9$) will become available on the output lines ($O_0 - O_7$).

Logic Block Diagram



Pin Configurations



Selection Guide

		7C281A-25 7C282A-25	7C281A-30 7C282A-30	7C281A-45 7C282A-45
Maximum Access Time (ns)		25	30	45
Maximum Operating Current (mA)	Commercial	100	100	90
	Military		120	120

Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature	-65°C to +150°C
Ambient Temperature with Power Applied	-55°C to +125°C
Supply Voltage to Ground Potential (Pin 24 to Pin 12)	-0.5V to +7.0V
DC Voltage Applied to Outputs in High Z State	-0.5V to +7.0V
DC Input Voltage	-3.0V to +7.0V
DC Program Voltage (Pins 18, 20)	13.0V

Static Discharge Voltage	>2001V (per MIL-STD-883, Method 3015)
Latch-Up Current	>200 mA

Operating Range

Range	Ambient Temperature	V _{CC}
Commercial	0°C to +70°C	5V ±10%
Industrial ^[1]	-40°C to +85°C	5V ±10%
Military ^[2]	-55°C to +125°C	5V ±10%

Electrical Characteristics Over the Operating Range^[3,4]

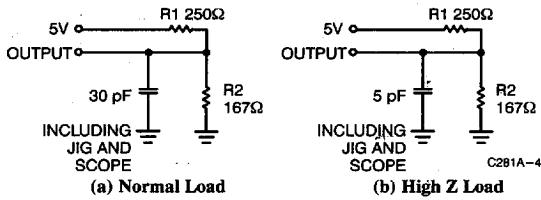
Parameter	Description	Test Conditions	7C281A-25 7C282A-25		7C281A-30 7C282A-30		7C281A-45 7C282A-45		Unit	
			Min.	Max.	Min.	Max.	Min.	Max.		
V _{OH}	Output HIGH Voltage	V _{CC} = Min., I _{OH} = -4.0 mA	2.4		2.4		2.4		V	
V _{OL}	Output LOW Voltage	V _{CC} = Min., I _{OL} = 16.0 mA		0.4		0.4		0.4	V	
V _{IH}	Input HIGH Level	Guaranteed Input Logical HIGH Voltage for All Inputs	2.0		2.0		2.0		V	
V _{IL}	Input LOW Level	Guaranteed Input Logical LOW Voltage for All Inputs		0.8		0.8		0.8	V	
I _{IX}	Input Current	GND ≤ V _{IN} ≤ V _{CC}	-10	+10	-10	+10	-10	+10	μA	
I _{OZ}	Output Leakage Current	GND ≤ V _{OUT} ≤ V _{CC} , Output Disabled	-10	+10	-10	+10	-10	+10	μA	
I _{OS}	Output Short Circuit Current ^[5]	V _{CC} = Max., V _{OUT} = GND	-20	-90	-20	-90	-20	-90	mA	
I _{CC}	Power Supply Current	V _{CC} = Max., I _{OUT} = 0 mA	Commercial		100		100		90	mA
			Military				120		120	
V _{PP}	Program Voltage		12	13	12	13	12	13	V	
V _{IHP}	Program HIGH Voltage		3.0		3.0		3.0		V	
V _{ILP}	Program LOW Voltage			0.4		0.4		0.4	V	
I _{PP}	Program Supply Current			50		50		50	mA	

Capacitance^[4]

Parameter	Description	Test Conditions	Max.	Unit
C _{IN}	Input Capacitance	T _A = 25°C, f = 1 MHz, V _{CC} = 5.0V	10	pF
C _{OUT}	Output Capacitance		10	pF

Notes:

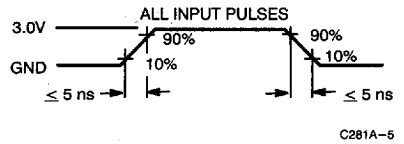
1. Contact a Cypress representative for industrial temperature range specifications.
2. T_A is the "instant on" case temperature.
3. See the last page of this specification for Group A subgroup testing information.
4. See "Introduction to CMOS PROMs" in this Data Book for general information on testing.
5. For test purposes, not more than one output at a time should be shorted. Short circuit test duration should not exceed 30 seconds.

AC Test Loads and Waveforms^[4]


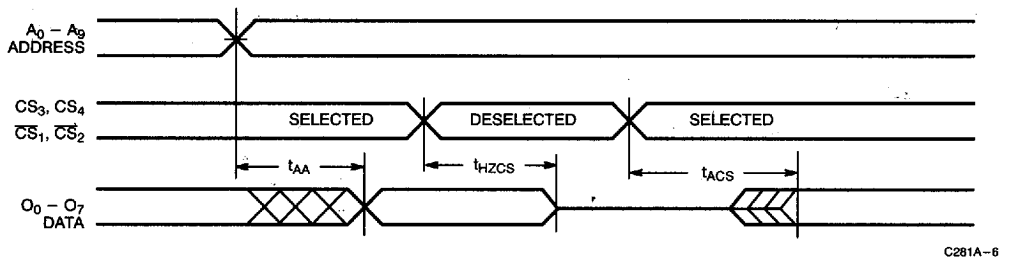
Equivalent to: THEVENIN EQUIVALENT

100Ω

OUTPUT ——— 2.0V


Switching Characteristics Over the Operating Range^[2,4]

Parameter	Description	7C281A-25 7C282A-25		7C281A-30 7C282A-30		7C281A-45 7C282A-45		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
t_{AA}	Address to Output Valid		25		30		45	ns
t_{HZCS}	Chip Select Inactive to High Z		15		20		25	ns
t_{ACS}	Chip Select Active to Output Valid		15		20		25	ns

Switching Waveforms


Programming Information

Programming support is available from Cypress as well as from a number of third party software vendors. For detailed programming information, including a listing of software packages, please see the

PROM Programming Information located at the end of this section. Programming algorithms can be obtained from any Cypress representative.

Table 1. Mode Selection

Mode	Pin Function ^[6]						
	Read or Output Disable	A ₉ - A ₀	CS ₄	CS ₃	CS ₂	CS ₁	O ₇ - O ₀
	Other	A ₉ - A ₀	PGM	V _{FY}	V _{PP}	CS ₁	D ₇ - D ₀
Read		A ₉ - A ₀	V _{IH}	V _{IH}	V _{IL}	V _{IL}	O ₇ - O ₀
Output Disable		A ₉ - A ₀	X	X	V _{IH}	X	High Z
Output Disable		A ₉ - A ₀	X	V _{IL}	X	X	High Z
Output Disable		A ₉ - A ₀	V _{IL}	X	X	X	High Z
Output Disable		A ₉ - A ₀	X	X	X	V _{IH}	High Z
Program		A ₉ - A ₀	V _{ILP}	V _{IHP}	V _{PP}	V _{ILP}	D ₇ - D ₀
Program Verify		A ₉ - A ₀	V _{IHP}	V _{ILP}	V _{PP}	V _{ILP}	O ₇ - O ₀
Program Inhibit		A ₉ - A ₀	V _{IHP}	V _{IHP}	V _{PP}	V _{ILP}	High Z
Intelligent Program		A ₉ - A ₀	V _{ILP}	V _{IHP}	V _{PP}	V _{ILP}	D ₇ - D ₀
Blank Check		A ₉ - A ₀	V _{IHP}	V _{ILP}	V _{PP}	V _{ILP}	Zeros

Note:

6. X = "don't care" but not to exceed V_{CC} ±5%.

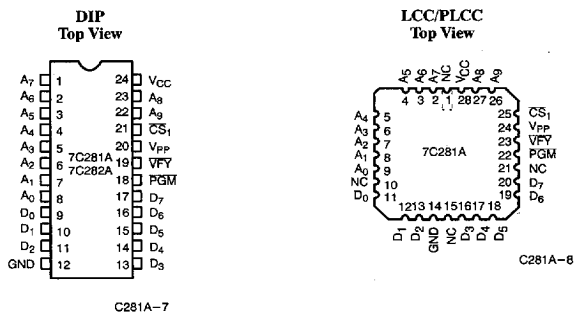
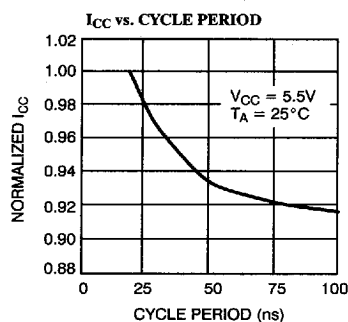
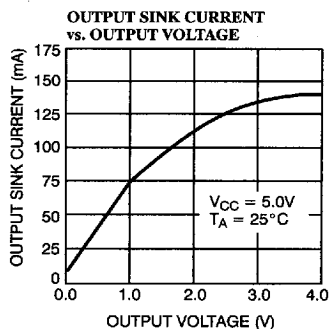
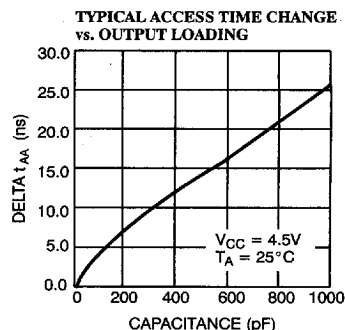
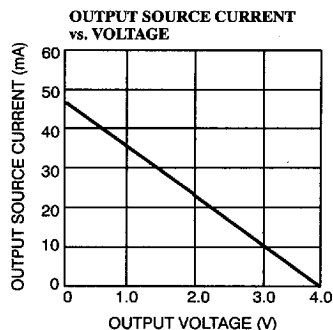
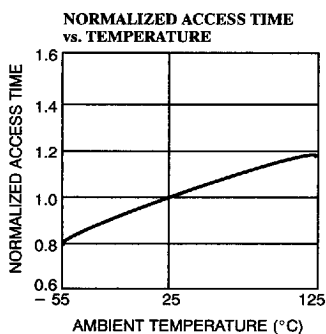
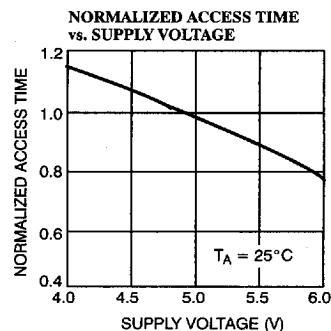
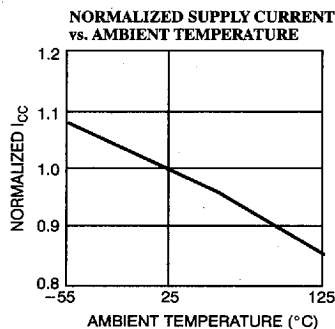
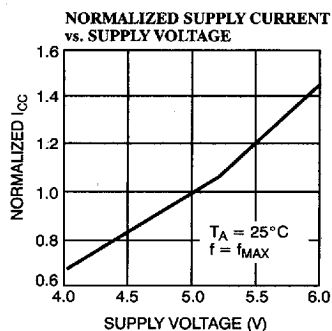


Figure 1. Programming Pinouts

Typical DC and AC Characteristics


Ordering Information

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
25	CY7C281A-25DC	D14	24-Lead (300-Mil) CerDIP	Commercial
	CY7C281A-25JC	J64	28-Lead Plastic Leaded Chip Carrier	
	CY7C281A-25PC	P13	24-Lead (300-Mil) Molded DIP	
30	CY7C281A-30DC	D14	24-Lead (300-Mil) CerDIP	Commercial
	CY7C281A-30JC	J64	28-Lead Plastic Leaded Chip Carrier	
	CY7C281A-30PC	P13	24-Lead (300-Mil) Molded DIP	
	CY7C281A-30DMB	D14	24-Lead (300-Mil) CerDIP	Military
45	CY7C281A-45DC	D14	24-Lead (300-Mil) CerDIP	Commercial
	CY7C281A-45JC	J64	28-Lead Plastic Leaded Chip Carrier	
	CY7C281A-45PC	P13	24-Lead (300-Mil) Molded DIP	
	CY7C281A-45DMB	D14	24-Lead (300-Mil) CerDIP	Military
	CY7C281A-45KMB	K73	24-Lead Rectangular Cerpack	

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
25	CY7C282A-25PC	P11	24-Lead (600-Mil) Molded DIP	Commercial
30	CY7C282A-30PC	P11	24-Lead (600-Mil) Molded DIP	Commercial
	CY7C282A-30DMB	D12	24-Lead (600-Mil) CerDIP	Military
45	CY7C282A-45PC	P11	24-Lead (600-Mil) Molded DIP	Commercial
	CY7C282A-45DMB	D12	24-Lead (600-Mil) CerDIP	Military

MILITARY SPECIFICATIONS
Group A Subgroup Testing
DC Characteristics

Parameter	Subgroups
V_{OH}	1, 2, 3
V_{OL}	1, 2, 3
V_{IH}	1, 2, 3
V_{IL}	1, 2, 3
I_{IX}	1, 2, 3
I_{OZ}	1, 2, 3
I_{CC}	1, 2, 3

Switching Characteristics

Parameter	Subgroups
t_{AA}	7, 8, 9, 10, 11
t_{ACS}	7, 8, 9, 10, 11

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